

# H5N2504DL, H5N2504DS

Silicon N Channel MOS FET  
High Speed Power Switching

## HITACHI

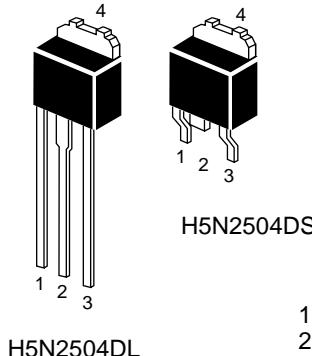
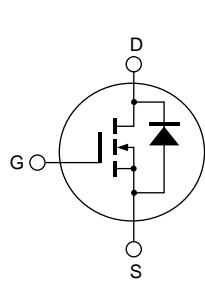
ADE-208-1375 (Z)  
1st. Edition  
Mar. 2001

### Features

- Low on-resistance
- Low leakage current
- High speed switching
- Low gate charge
- Avalanche ratings

### Outline

DPAK-2



H5N2504DL

H5N2504DS

1. Gate
2. Drain
3. Source
4. Drain

# H5N2504DL, H5N2504DS

## Absolute Maximum Ratings (Ta = 25°C)

Item	Symbol	Ratings	Unit
Drain to source voltage	V <sub>DSS</sub>	250	V
Gate to source voltage	V <sub>GSS</sub>	±20	V
Drain current	I <sub>D</sub>	7	A
Drain peak current	I <sub>D</sub> (pulse) <sup>Note1</sup>	28	A
Body-drain diode reverse drain current	I <sub>DR</sub>	7	A
Body-drain diode reverse drain peak current	I <sub>DR</sub> (pulse) <sup>Note1</sup>	28	A
Channel dissipation	P <sub>ch</sub> <sup>Note2</sup>	30	W
Channel to case Thermal Impedance	θ <sub>ch-c</sub>	4.17	°C/W
Channel temperature	T <sub>ch</sub>	150	°C
Storage temperature	T <sub>stg</sub>	-55 to +150	°C

Notes: 1. PW 10 µs, duty cycle 1%

2. Value at T<sub>c</sub> = 25°C

3. T<sub>ch</sub> 150°C

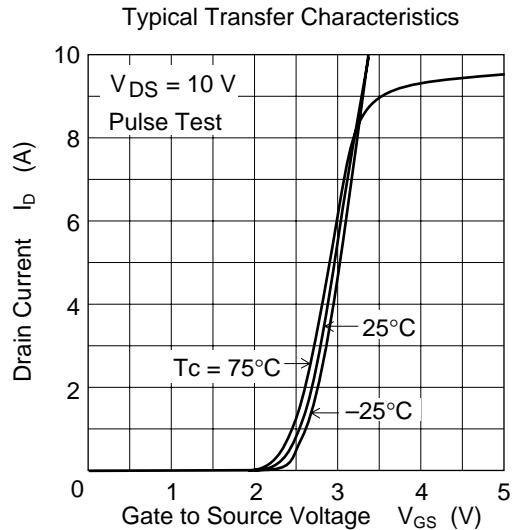
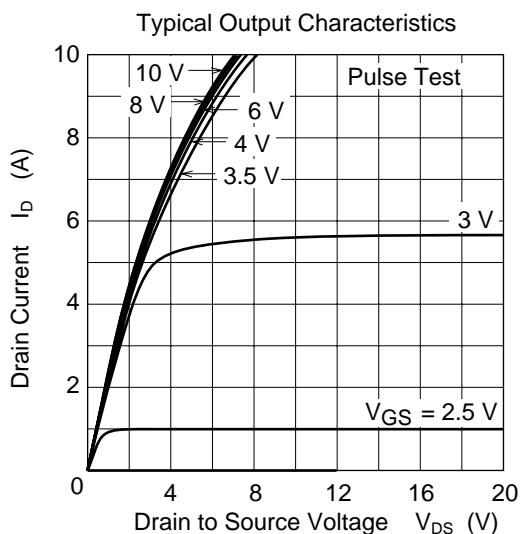
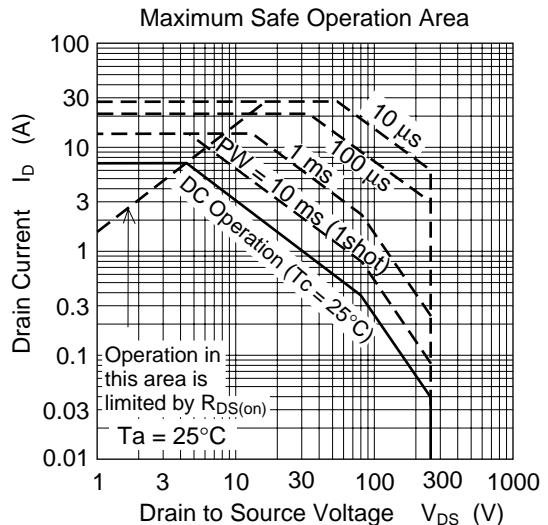
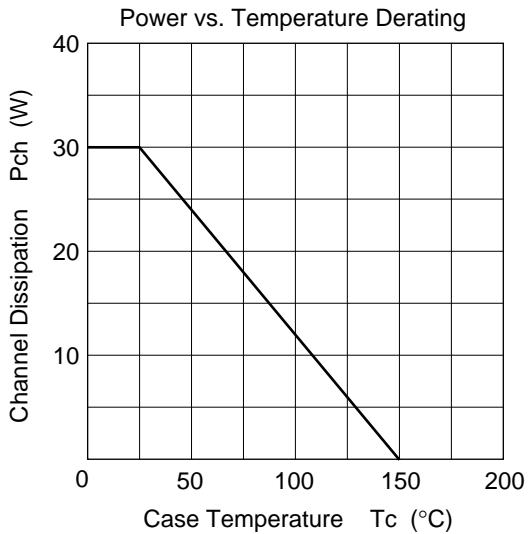
**Electrical Characteristics (Ta = 25°C)**

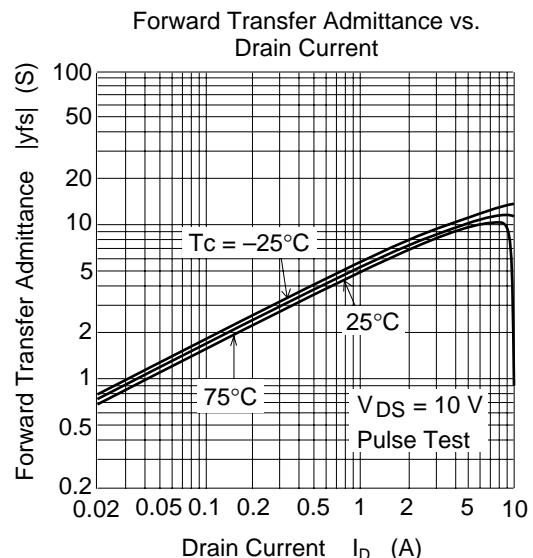
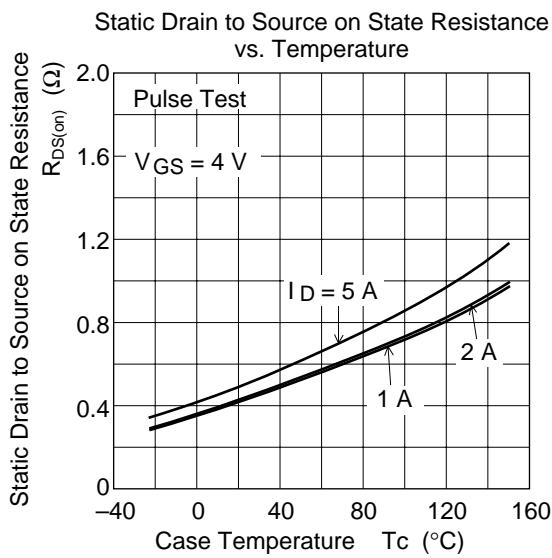
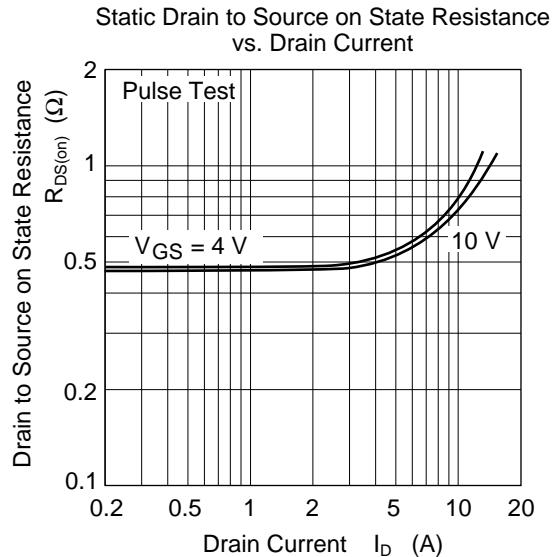
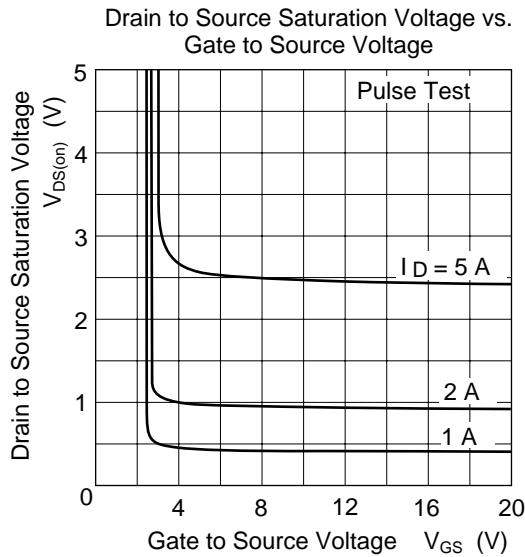
<b>Item</b>	<b>Symbol</b>	<b>Min</b>	<b>Typ</b>	<b>Max</b>	<b>Unit</b>	<b>Test conditions</b>
Drain to source breakdown voltage	V <sub>(BR)DSS</sub>	250	—	—	V	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0
Gate to source leak current	I <sub>GSS</sub>	—	—	±0.1	µA	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0
Zero gate voltage drain current	I <sub>DSS</sub>	—	—	1	µA	V <sub>DS</sub> = 250 V, V <sub>GS</sub> = 0
Gate to source cutoff voltage	V <sub>GS(off)</sub>	1.0	—	2.5	V	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA
Static drain to source on state resistance	R <sub>DS(on)</sub>	—	0.48	0.63		I <sub>D</sub> = 3.5 A, V <sub>GS</sub> = 10 V <sup>Note4</sup>
Forward transfer admittance	y <sub>fs</sub>	5	8.5	—	S	I <sub>D</sub> = 3.5 A, V <sub>DS</sub> = 10 V <sup>Note4</sup>
Input capacitance	C <sub>iss</sub>	—	570	—	pF	V <sub>DS</sub> = 25 V
Output capacitance	C <sub>oss</sub>	—	60	—	pF	V <sub>GS</sub> = 0
Reverse transfer capacitance	C <sub>rss</sub>	—	12	—	pF	f = 1 MHz
Turn-on delay time	t <sub>d(on)</sub>	—	13	—	ns	I <sub>D</sub> = 3.5 A
Rise time	t <sub>r</sub>	—	18	—	ns	V <sub>GS</sub> = 10 V
Turn-off delay time	t <sub>d(off)</sub>	—	70	—	ns	R <sub>L</sub> = 35.7
Fall time	t <sub>f</sub>	—	8	—	ns	R <sub>g</sub> = 10
Total gate charge	Q <sub>g</sub>	—	21	—	nC	V <sub>DD</sub> = 200 V
Gate to source charge	Q <sub>gs</sub>	—	2	—	nC	V <sub>GS</sub> = 10 V
Gate to drain charge	Q <sub>gd</sub>	—	6	—	nC	I <sub>D</sub> = 7 A
Body-drain diode forward voltage	V <sub>DF</sub>	—	0.85	1.30	V	I <sub>F</sub> = 7 A, V <sub>GS</sub> = 0
Body-drain diode reverse recovery time	t <sub>rr</sub>	—	120	—	ns	I <sub>F</sub> = 7 A, V <sub>GS</sub> = 0
Body-drain diode reverse recovery charge	Q <sub>rr</sub>	—	0.48	—	µC	dI/dt = 100 A/µs

Note: 4. Pulse test

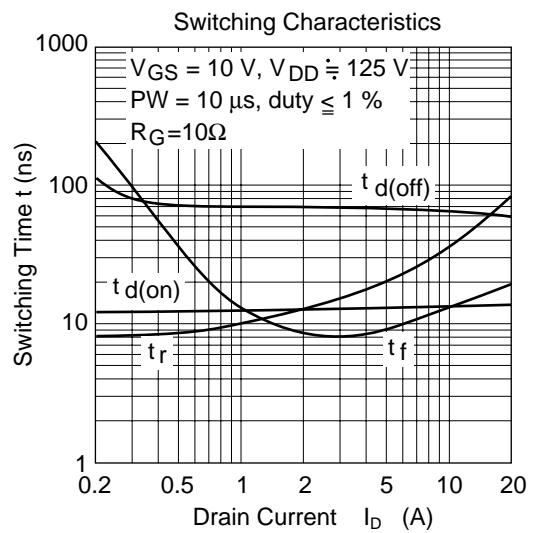
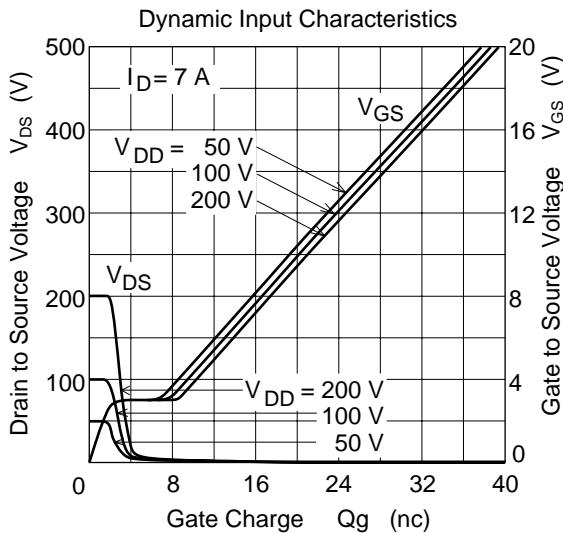
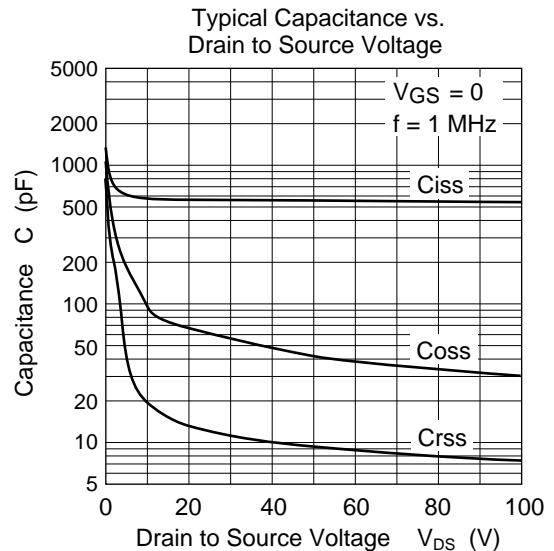
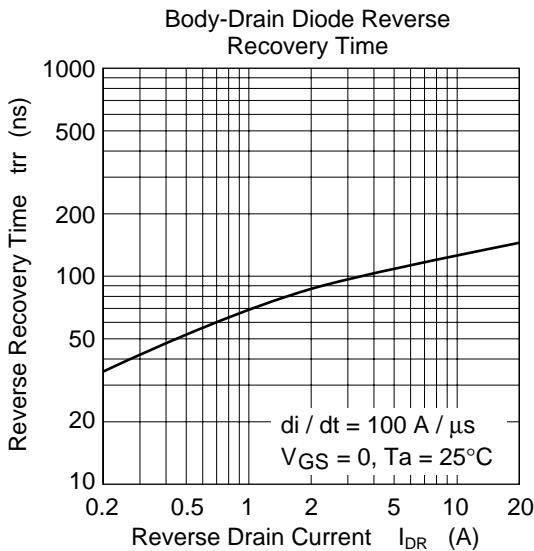
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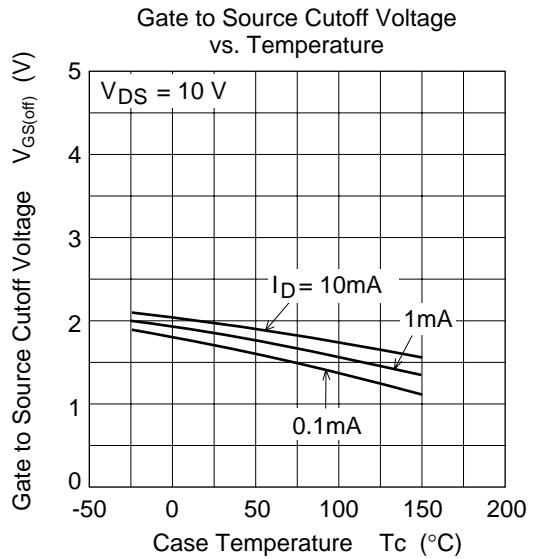
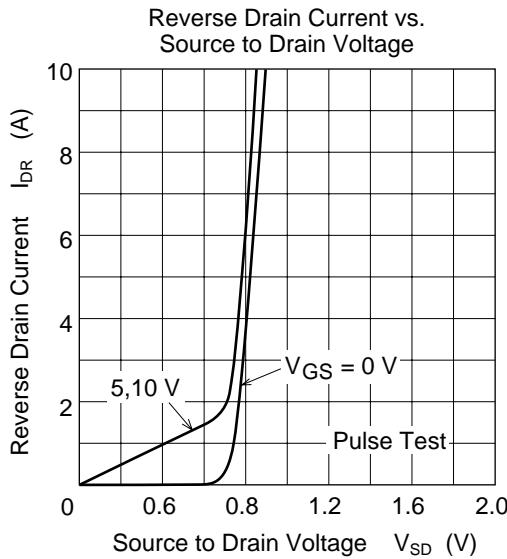
## Main Characteristics



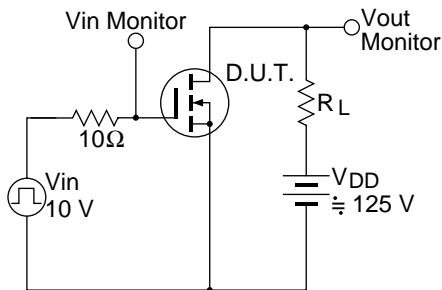


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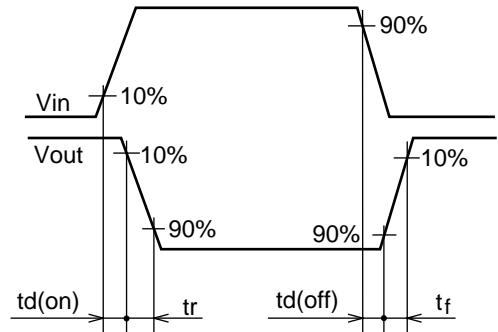


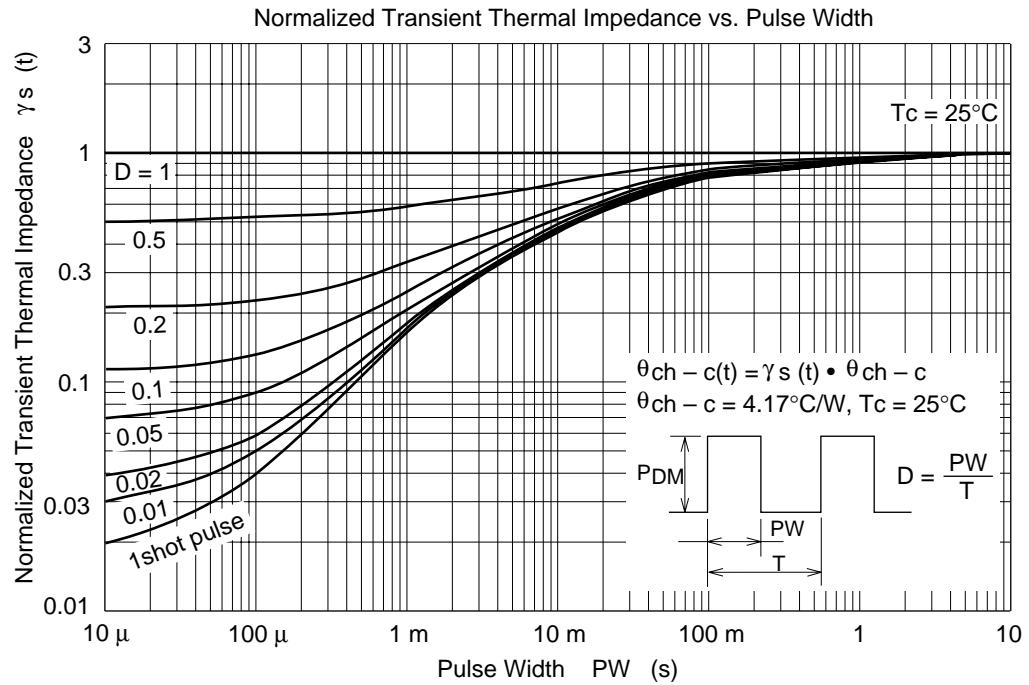


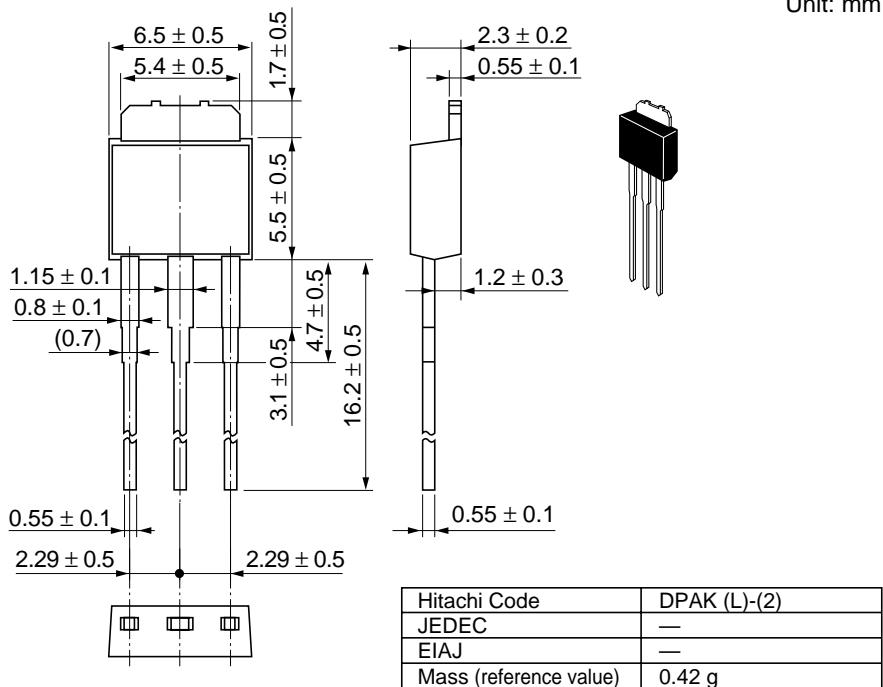
Switching Time Test Circuit



Waveform

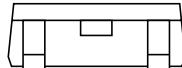
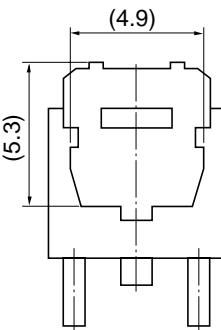
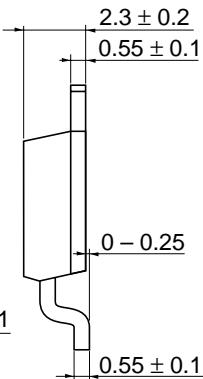
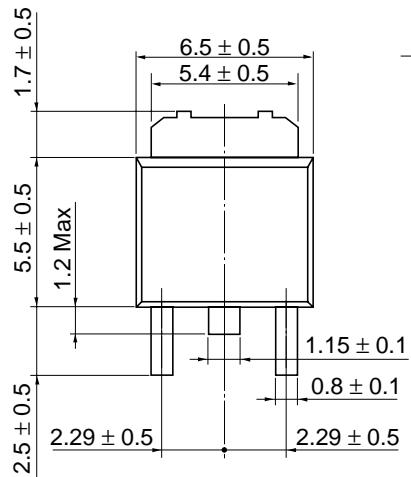




**Package Dimensions**As of January, 2001  
Unit: mm

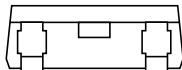
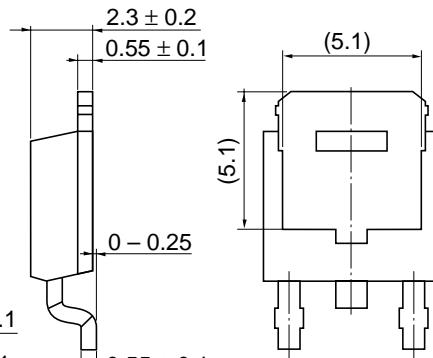
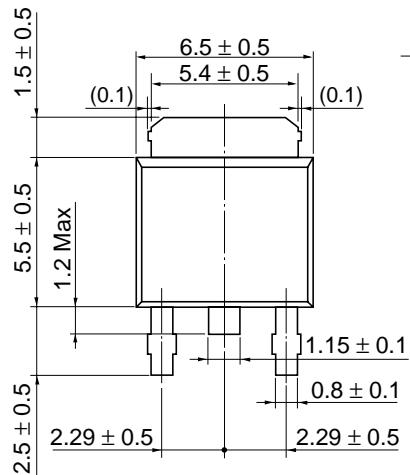
# H5N2504DL, H5N2504DS

As of January, 2001  
Unit: mm



Hitachi Code	DPAK (S)-(1),(2)
JEDEC	—
EIAJ	Conforms
Mass (reference value)	0.28 g

**HITACHI**

As of January, 2001  
Unit: mm

Hitachi Code	DPAK (S)-(3)
JEDEC	—
EIAJ	Conforms
Mass (reference value)	0.28 g

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